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# HM5225645F-B60

# HM5225325F-B60

256M LVTTL interface SDRAM  
100 MHz

1-Mword  $\times$  64-bit  $\times$  4-bank/2-Mword  $\times$  32-bit  $\times$  4-bank  
PC/100 SDRAM

# HITACHI

ADE-203-1014C (Z)  
Rev. 1.0  
Oct. 1, 1999

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## Description

The Hitachi HM5225645F is a 256-Mbit SDRAM organized as 1048576-word  $\times$  64-bit  $\times$  4-bank. The Hitachi HM5225325F is a 256-Mbit SDRAM organized as 2097152-word  $\times$  32-bit  $\times$  4-bank. All inputs and outputs are referred to the rising edge of the clock input. It is packaged in standard 108 bump BGA.

## Features

- Single chip wide bit solution ( $\times$  64/ $\times$  32)
- 3.3 V power supply
- Clock frequency: 100 MHz (max)
- LVTTL interface
- Extremely small foot print: 1.27 mm pitch
  - Package: BGA (BP-108)
- 4 banks can operate simultaneously and independently
- Burst read/write operation and burst read/single write operation capability
- Programmable burst length: 4/8/full page
- 2 variations of burst sequence
  - Sequential (BL = 4/8/full page)
  - Interleave (BL = 4/8)
- Programmable  $\overline{\text{CAS}}$  latency: 2/3
- Byte control by DQMB

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- Refresh cycles: 4096 refresh cycles/64 ms
- 2 variations of refresh
  - Auto refresh
  - Self refresh
- Full page burst length capability
  - Sequential burst
  - Burst stop capability

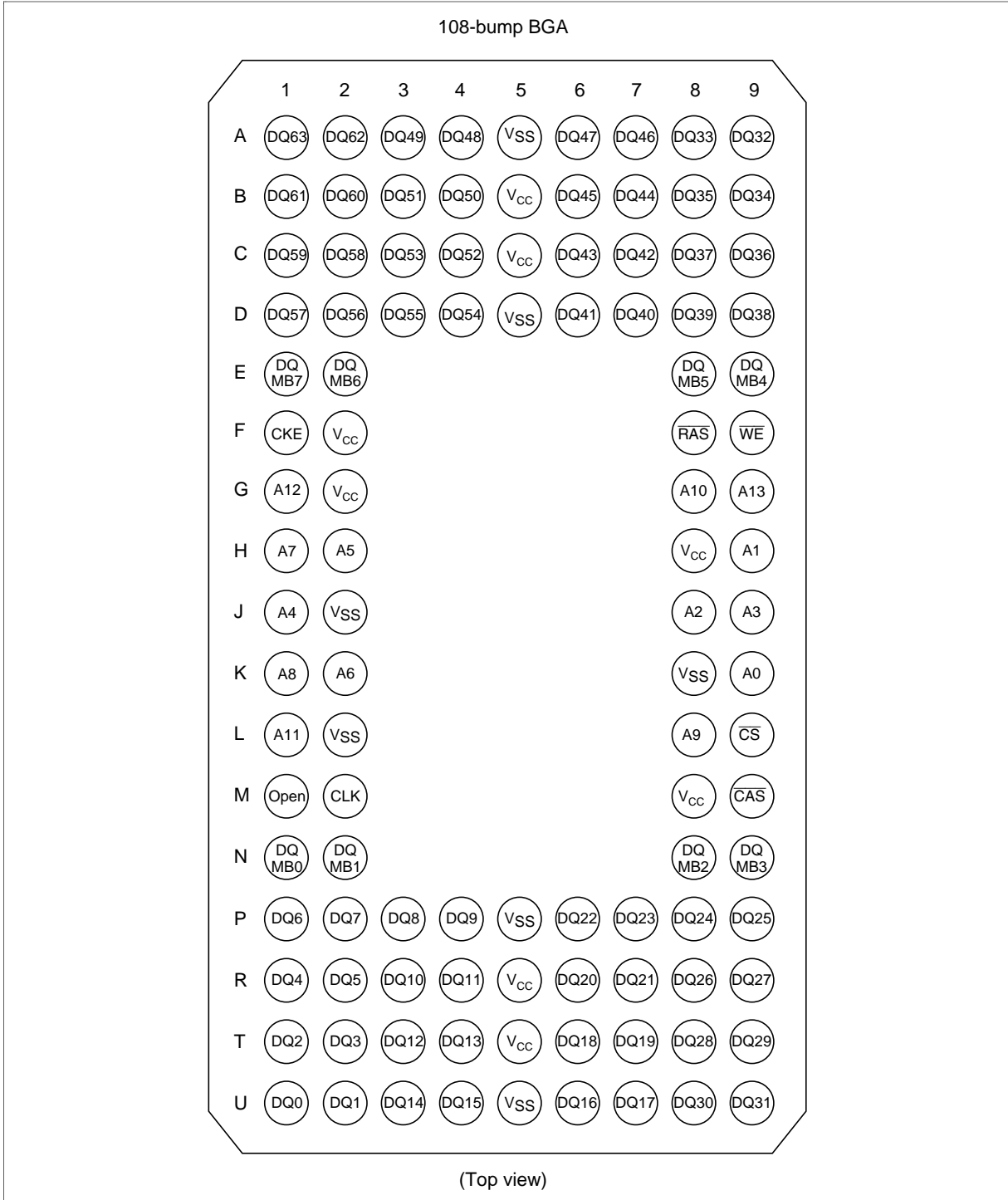
### Ordering Information

| Type No.          | Frequency | $\overline{\text{CAS}}$ latency | Package                             |
|-------------------|-----------|---------------------------------|-------------------------------------|
| HM5225645FBP-B60* | 100 MHz   | 3                               | 14 mm × 22 mm 108 bump BGA (BP-108) |
| HM5225325FBP-B60* | 100 MHz   | 3                               |                                     |

Note: 66 MHz operation at  $\overline{\text{CAS}}$  latency = 2.

# HM5225645F-B60, HM5225325F-B60

## Pin Arrangement (HM5225645F)



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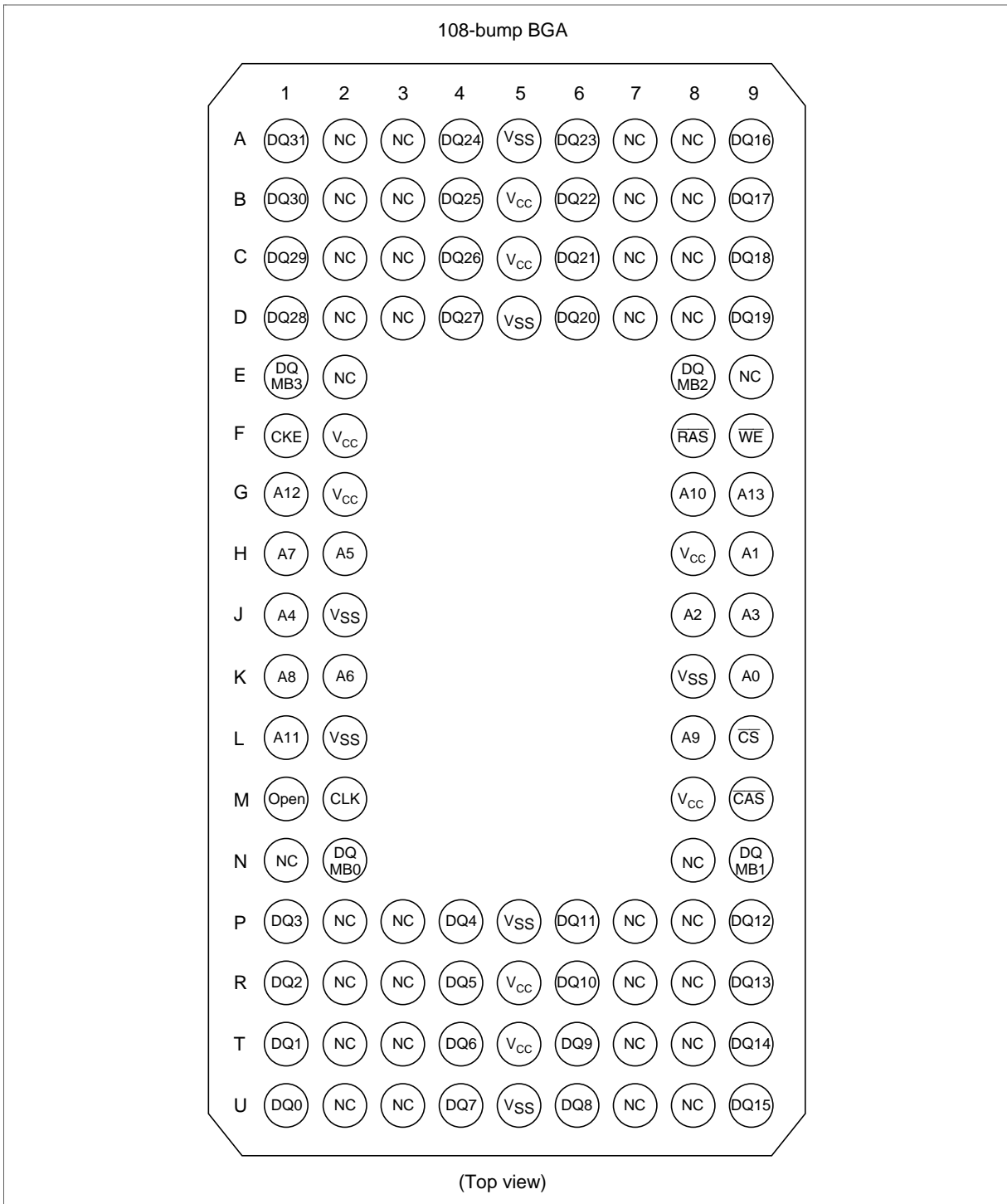
### Pin Description (HM5225645F)

| Pin name         | Function  |
|------------------|---|
| A0 to A13        | Address input<br>Row address A0 to A11<br>Column address A0 to A7<br>Bank select address A12/A13 (BS) |
| DQ0 to DQ63      | Data-input/output   |
| $\overline{CS}$  | Chip select   |
| $\overline{RAS}$ | Row address strobe command  |
| $\overline{CAS}$ | Column address strobe command   |
| $\overline{WE}$  | Write enable  |
| DQMB0 to DQMB7   | Byte data mask* <sup>1</sup>  |
| CLK              | Clock input   |
| CKE              | Clock enable  |
| V <sub>cc</sub>  | Power supply  |
| V <sub>ss</sub>  | Ground  |
| Open             | Open* <sup>2</sup>  |

- Note:
1. DQMB0: DQ0 to DQ7  
DQMB1: DQ8 to DQ15  
DQMB2: DQ16 to DQ23  
DQMB3: DQ24 to DQ31  
DQMB4: DQ32 to DQ39  
DQMB5: DQ40 to DQ47  
DQMB6: DQ48 to DQ55  
DQMB7: DQ56 to DQ63
  2. Don't connect. Internally connected with die.

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## Pin Arrangement (HM5225325F)



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## HM5225645F-B60, HM5225325F-B60

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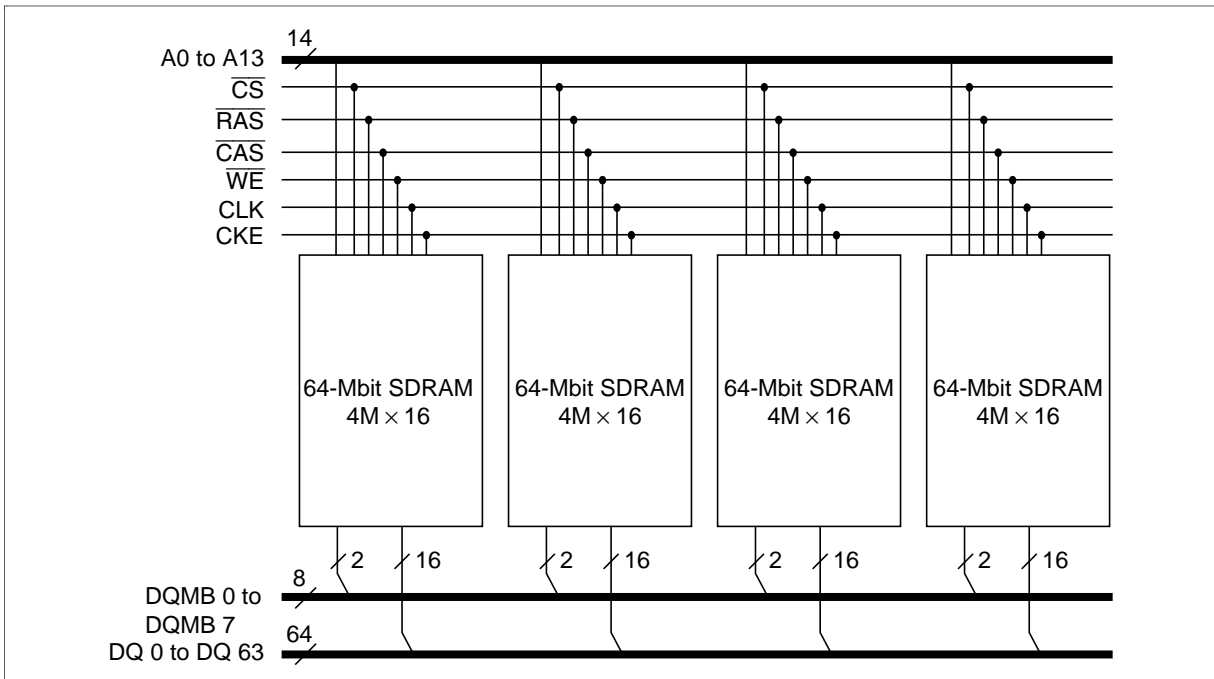
### Pin Description (HM5225325F)

| Pin name         | Function  |
|------------------|---|
| A0 to A13        | Address input<br>Row address A0 to A11<br>Column address A0 to A8<br>Bank select address A12/A13 (BS) |
| DQ0 to DQ31      | Data-input/output   |
| $\overline{CS}$  | Chip select   |
| $\overline{RAS}$ | Row address strobe command  |
| $\overline{CAS}$ | Column address strobe command   |
| $\overline{WE}$  | Write enable  |
| DQMB0 to DQMB3   | Byte data mask* <sup>1</sup>  |
| CLK              | Clock input   |
| CKE              | Clock enable  |
| V <sub>cc</sub>  | Power supply  |
| V <sub>ss</sub>  | Ground  |
| Open             | Open* <sup>2</sup>  |
| NC               | No connection* <sup>3</sup>   |

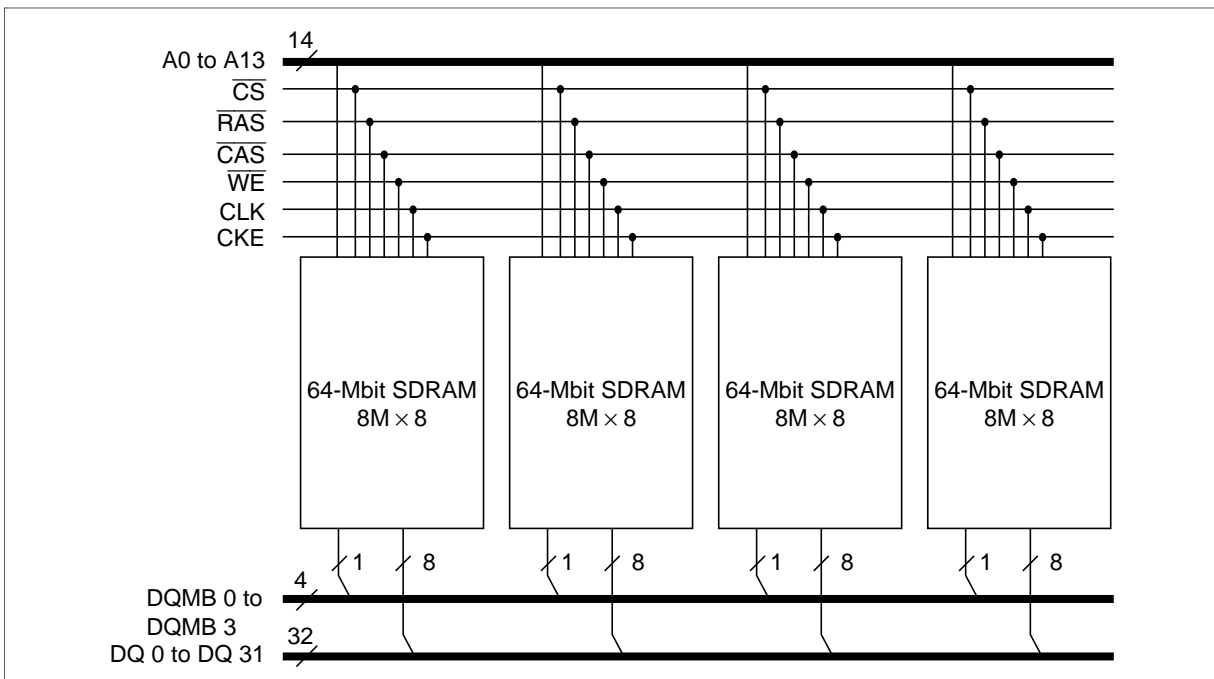
- Note:
1. DQMB0: DQ0 to DQ7  
DQMB1: DQ8 to DQ15  
DQMB2: DQ16 to DQ23  
DQMB3: DQ24 to DQ31
  2. Don't connect. Internally connected with die.
  3. Not internally connected with die.

# HM5225645F-B60, HM5225325F-B60

## Block Diagram (HM5225645F)

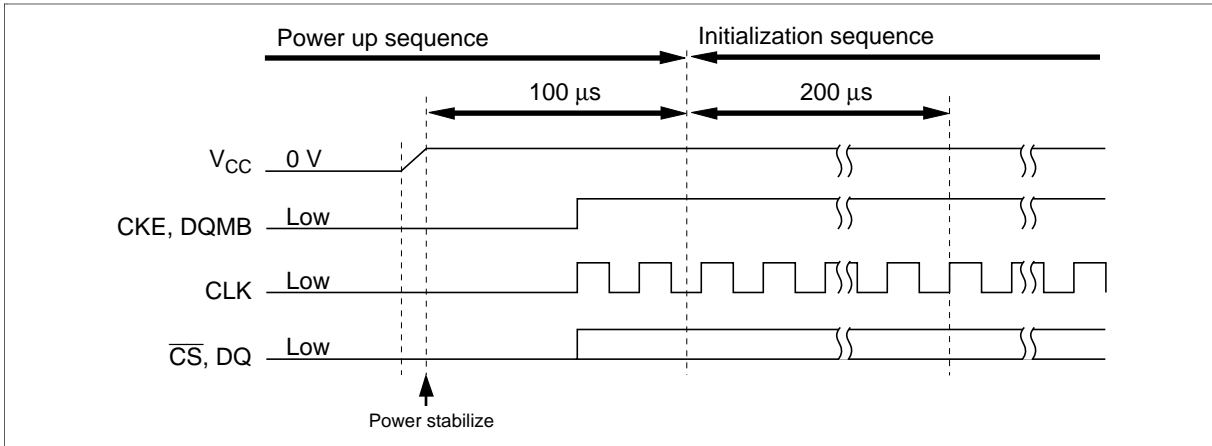


## Block Diagram (HM5225325F)



## HM5225645F-B60, HM5225325F-B60

### Power-up Sequence and Initialization Sequence



### Absolute Maximum Ratings

| Parameter                                      | Symbol           | Value  | Unit | Note |
|--|------------------|--|------|------|
| Voltage on any pin relative to V <sub>SS</sub> | V <sub>T</sub>   | -0.5 to V <sub>CC</sub> + 0.5<br>(≤ 4.6 (max)) | V    | 1    |
| Supply voltage relative to V <sub>SS</sub>     | V <sub>CC</sub>  | -0.5 to +4.6                                   | V    | 1    |
| Short circuit output current                   | I <sub>out</sub> | 50   | mA   |      |
| Operating temperature                          | T <sub>opr</sub> | 0 to +70 (T <sub>j</sub> max = 110)            | °C   |      |
| Storage temperature                            | T <sub>stg</sub> | -55 to +125                                    | °C   |      |

Note: 1. Respect to V<sub>SS</sub>

### DC Operating Conditions (T<sub>case</sub> = 0 to +70°C [T<sub>j</sub> max = 110°C])

| Parameter          | Symbol          | Min  | Max                   | Unit | Notes |
|--------------------|-----------------|------|-----------------------|------|-------|
| Supply voltage     | V <sub>CC</sub> | 3.0  | 3.6                   | V    | 1, 2  |
|                    | V <sub>SS</sub> | 0    | 0                     | V    | 3     |
| Input high voltage | V <sub>IH</sub> | 2.0  | V <sub>CC</sub> + 0.3 | V    | 1, 4  |
| Input low voltage  | V <sub>IL</sub> | -0.3 | 0.8                   | V    | 1, 5  |

Notes: 1. All voltage referred to V<sub>SS</sub>

- The supply voltage with all V<sub>CC</sub> pins must be on the same level.
- The supply voltage with all V<sub>SS</sub> pins must be on the same level.
- V<sub>IH</sub> (max) = V<sub>CC</sub> + 2.0 V for pulse width ≤ 3 ns at V<sub>CC</sub>.
- V<sub>IL</sub> (min) = V<sub>SS</sub> - 2.0 V for pulse width ≤ 3 ns at V<sub>SS</sub>.



## HM5225645F-B60, HM5225325F-B60

### DC Characteristics

(T<sub>case</sub> = 0 to 70°C [T<sub>j</sub> max = 110°C]), V<sub>CC</sub> = 3.3 V ± 0.3 V, V<sub>SS</sub> = 0 V) (HM5225645F)

| Parameter   | Symbol             | HM5225645F |     | Unit | Test conditions  | Notes   |
|---|--------------------|------------|-----|------|--|---------|
|   |                    | -B60       |     |      |  |         |
|   |                    | Min        | Max |      |  |         |
| Operating current<br>(CAS latency = 2)                            | I <sub>CC1</sub>   | —          | 200 | mA   | Burst length = 1<br>t <sub>RC</sub> = min                                  | 1, 2, 3 |
|   | I <sub>CC1</sub>   | —          | 220 |      |  |         |
| Standby current in power down                                     | I <sub>CC2P</sub>  | —          | 12  | mA   | CKE = V <sub>IL</sub> ,<br>t <sub>CK</sub> = 12 ns                         | 6       |
| Standby current in power down<br>(input signal stable)            | I <sub>CC2PS</sub> | —          | 8   | mA   | CKE = V <sub>IL</sub> , t <sub>CK</sub> = ∞                                | 7       |
| Standby current in non power<br>down                              | I <sub>CC2N</sub>  | —          | 64  | mA   | CKE, $\overline{\text{CS}}$ = V <sub>IH</sub> ,<br>t <sub>CK</sub> = 12 ns | 4       |
| Standby current in non power<br>down (input signal stable)        | I <sub>CC2NS</sub> | —          | 36  | mA   | CKE = V <sub>IH</sub> , t <sub>CK</sub> = ∞                                | 9       |
| Active standby current in power<br>down                           | I <sub>CC3P</sub>  | —          | 16  | mA   | CKE = V <sub>IL</sub> ,<br>t <sub>CK</sub> = 12 ns                         | 1, 2, 6 |
| Active standby current in power<br>down (input signal stable)     | I <sub>CC3PS</sub> | —          | 12  | mA   | CKE = V <sub>IL</sub> , t <sub>CK</sub> = ∞                                | 2, 7    |
| Active standby current in non<br>power down                       | I <sub>CC3N</sub>  | —          | 80  | mA   | CKE, $\overline{\text{CS}}$ = V <sub>IH</sub> ,<br>t <sub>CK</sub> = 12 ns | 1, 2, 4 |
| Active standby current in non<br>power down (input signal stable) | I <sub>CC3NS</sub> | —          | 60  | mA   | CKE = V <sub>IH</sub> , t <sub>CK</sub> = ∞                                | 2, 9    |
| Burst operating current<br>(CAS latency = 2)                      | I <sub>CC4</sub>   | —          | 220 | mA   | t <sub>CK</sub> = min, BL = 4  | 1, 2, 5 |
|   | I <sub>CC4</sub>   | —          | 270 |      |  |         |
| Refresh current   | I <sub>CC5</sub>   | —          | 380 | mA   | t <sub>RC</sub> = min  | 3       |
| Self refresh current  | I <sub>CC6</sub>   | —          | 4   | mA   | V <sub>IH</sub> ≥ V <sub>CC</sub> - 0.2 V<br>V <sub>IL</sub> ≤ 0.2 V       | 8       |
| Self refresh current (L-version)                                  | I <sub>CC6</sub>   | —          | 1.6 | mA   |  |         |
| Input leakage current   | I <sub>LI</sub>    | -4         | 4   | μA   | 0 ≤ Vin ≤ V <sub>CC</sub>  |         |
| Output leakage current  | I <sub>LO</sub>    | -6         | 6   | μA   | 0 ≤ Vout ≤ V <sub>CC</sub><br>DQ = disable                                 |         |
| Output high voltage   | V <sub>OH</sub>    | 2.4        | —   | V    | I <sub>OH</sub> = -4 mA  |         |
| Output low voltage  | V <sub>OL</sub>    | —          | 0.4 | V    | I <sub>OL</sub> = 4 mA   |         |

## HM5225645F-B60, HM5225325F-B60

### DC Characteristics

(T<sub>case</sub> = 0 to 70°C [T<sub>j</sub> max = 110°C]), V<sub>CC</sub> = 3.3 V ± 0.3 V, V<sub>SS</sub> = 0 V) (HM5225325F)

| Parameter   | Symbol             | HM5225325F |     | Unit | Test conditions  | Notes   |
|---|--------------------|------------|-----|------|--|---------|
|   |                    | -B60       |     |      |  |         |
|   |                    | Min        | Max |      |  |         |
| Operating current<br>(CAS latency = 2)                            | I <sub>CC1</sub>   | —          | 180 | mA   | Burst length = 1<br>t <sub>RC</sub> = min                                  | 1, 2, 3 |
|   | I <sub>CC1</sub>   | —          | 200 |      |  |         |
| Standby current in power down                                     | I <sub>CC2P</sub>  | —          | 12  | mA   | CKE = V <sub>IL</sub> ,<br>t <sub>CK</sub> = 12 ns                         | 6       |
| Standby current in power down<br>(input signal stable)            | I <sub>CC2PS</sub> | —          | 8   | mA   | CKE = V <sub>IL</sub> , t <sub>CK</sub> = ∞                                | 7       |
| Standby current in non power<br>down                              | I <sub>CC2N</sub>  | —          | 64  | mA   | CKE, $\overline{\text{CS}}$ = V <sub>IH</sub> ,<br>t <sub>CK</sub> = 12 ns | 4       |
| Standby current in non power<br>down (input signal stable)        | I <sub>CC2NS</sub> | —          | 36  | mA   | CKE = V <sub>IH</sub> , t <sub>CK</sub> = ∞                                | 9       |
| Active standby current in power<br>down                           | I <sub>CC3P</sub>  | —          | 16  | mA   | CKE = V <sub>IL</sub> ,<br>t <sub>CK</sub> = 12 ns                         | 1, 2, 6 |
| Active standby current in power<br>down (input signal stable)     | I <sub>CC3PS</sub> | —          | 12  | mA   | CKE = V <sub>IL</sub> , t <sub>CK</sub> = ∞                                | 2, 7    |
| Active standby current in non<br>power down                       | I <sub>CC3N</sub>  | —          | 80  | mA   | CKE, $\overline{\text{CS}}$ = V <sub>IH</sub> ,<br>t <sub>CK</sub> = 12 ns | 1, 2, 4 |
| Active standby current in non<br>power down (input signal stable) | I <sub>CC3NS</sub> | —          | 60  | mA   | CKE = V <sub>IH</sub> , t <sub>CK</sub> = ∞                                | 2, 9    |
| Burst operating current<br>(CAS latency = 2)                      | I <sub>CC4</sub>   | —          | 200 | mA   | t <sub>CK</sub> = min, BL = 4  | 1, 2, 5 |
|   | I <sub>CC4</sub>   | —          | 250 |      |  |         |
| Refresh current   | I <sub>CC5</sub>   | —          | 380 | mA   | t <sub>RC</sub> = min  | 3       |
| Self refresh current  | I <sub>CC6</sub>   | —          | 4   | mA   | V <sub>IH</sub> ≥ V <sub>CC</sub> - 0.2 V<br>V <sub>IL</sub> ≤ 0.2 V       | 8       |
| Self refresh current (L-version)                                  | I <sub>CC6</sub>   | —          | 1.6 | mA   |  |         |
| Input leakage current   | I <sub>LI</sub>    | -4         | 4   | μA   | 0 ≤ Vin ≤ V <sub>CC</sub>  |         |
| Output leakage current  | I <sub>LO</sub>    | -6         | 6   | μA   | 0 ≤ Vout ≤ V <sub>CC</sub><br>DQ = disable                                 |         |
| Output high voltage   | V <sub>OH</sub>    | 2.4        | —   | V    | I <sub>OH</sub> = -4 mA  |         |
| Output low voltage  | V <sub>OL</sub>    | —          | 0.4 | V    | I <sub>OL</sub> = 4 mA   |         |

## HM5225645F-B60, HM5225325F-B60

- Notes: 1.  $I_{CC}$  depends on output load condition when the device is selected.  $I_{CC}$  (max) is specified at the output open condition.
2. One bank operation.
  3. Input signals are changed once per one clock.
  4. Input signals are changed once per two clocks.
  5. Input signals are changed once per four clocks.
  6. After power down mode, CLK operating current.
  7. After power down mode, no CLK operating current.
  8. After self refresh mode set, self refresh current.
  9. Input signals are  $V_{IH}$  or  $V_{IL}$  fixed.

### Capacitance ( $T_a = 25^\circ\text{C}$ , $V_{CC} = 3.3 \text{ V} \pm 0.3 \text{ V}$ )

| Parameter                               | Symbol   | Min | Max | Unit | Notes      |
|---|----------|-----|-----|------|------------|
| Input capacitance (CLK)                 | $C_{i1}$ | 10  | 14  | pF   | 1, 2, 4    |
| Input capacitance<br>(Input except DQM) | $C_{i2}$ | 10  | 14  | pF   | 1, 2, 4    |
| Input capacitance (DQM)                 | $C_{i3}$ | 2.5 | 5   | pF   | 1, 2, 4    |
| Output capacitance (DQ)                 | $C_o$    | 3   | 5   | pF   | 1, 2, 3, 4 |

- Notes: 1. Capacitance measured with Boonton Meter or effective capacitance measuring method.
2. Measurement condition:  $f = 1 \text{ MHz}$ ,  $1.4 \text{ V}$  bias,  $200 \text{ mV}$  swing.
  3.  $DQMB = V_{IH}$  to disable Dout.
  4. This parameter is sampled and not 100% tested.

## HM5225645F-B60, HM5225325F-B60

### AC Characteristics

(T<sub>case</sub> = 0 to 70°C [T<sub>j</sub> max = 110°C]), V<sub>CC</sub> = 3.3 V ± 0.3 V, V<sub>SS</sub> = 0 V)

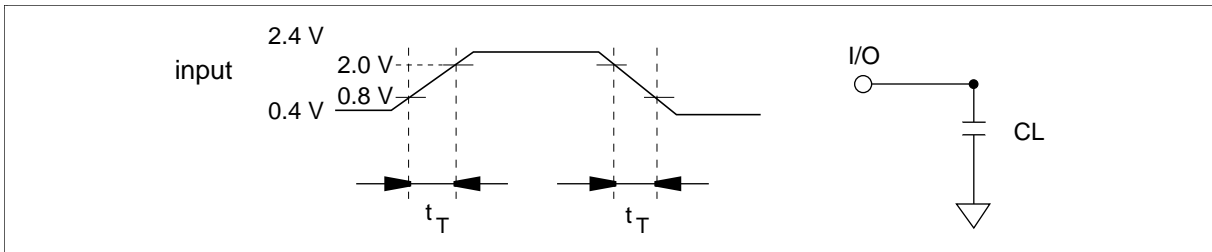
| Parameter  | HITACHI<br>Symbol   | PC/100<br>Symbol | HM5225645F/HM5225325F |        | Unit | Notes   |
|--|---|------------------|-----------------------|--------|------|---------|
|  |   |                  | Min                   | Max    |      |         |
| System clock cycle time<br>(CAS latency = 2)           | t <sub>CK</sub>   | Tclk             | 15                    | —      | ns   | 1       |
| (CAS latency = 3)                                      | t <sub>CK</sub>   | Tclk             | 10                    | —      | ns   |         |
| CLK high pulse width                                   | t <sub>CKH</sub>  | Tch              | 3                     | —      | ns   | 1       |
| CLK low pulse width                                    | t <sub>CKL</sub>  | Tcl              | 3                     | —      | ns   | 1       |
| Access time from CLK<br>(CAS latency = 2)              | t <sub>AC</sub>   | Tac              | —                     | 8      | ns   | 1, 2    |
| (CAS latency = 3)                                      | t <sub>AC</sub>   | Tac              | —                     | 6      | ns   |         |
| Data-out hold time                                     | t <sub>OH</sub>   | Toh              | 3                     | —      | ns   | 1, 2    |
| CLK to Data-out low impedance                          | t <sub>LZ</sub>   |                  | 2                     | —      | ns   | 1, 2, 3 |
| CLK to Data-out high impedance<br>(CAS latency = 2, 3) | t <sub>HZ</sub>   |                  | —                     | 6      | ns   | 1, 4    |
| Input setup time                                       | t <sub>AS</sub> , t <sub>CS</sub> , t <sub>DS</sub> ,<br>t <sub>CES</sub> | Tsi              | 2                     | —      | ns   | 1, 5, 6 |
| CKE setup time for power down<br>exit                  | t <sub>CESP</sub>   | Tpde             | 2                     | —      | ns   | 1       |
| Input hold time  | t <sub>AH</sub> , t <sub>CH</sub> , t <sub>DH</sub> ,<br>t <sub>CEH</sub> | Thi              | 1                     | —      | ns   | 1, 5    |
| Ref/Active to Ref/Active command<br>period             | t <sub>RC</sub>   | Trc              | 70                    | —      | ns   | 1       |
| Active to Precharge command<br>period                  | t <sub>RAS</sub>  | Tras             | 50                    | 120000 | ns   | 1       |
| Active command to column<br>command (same bank)        | t <sub>RCD</sub>  | Trcd             | 20                    | —      | ns   | 1       |
| Precharge to active command<br>period                  | t <sub>RP</sub>   | Trp              | 20                    | —      | ns   | 1       |
| Write recovery or data-in to<br>precharge lead time    | t <sub>DPL</sub>  | Tdpl             | 10                    | —      | ns   | 1       |
| Active (a) to Active (b) command<br>period             | t <sub>RRD</sub>  | Trrd             | 20                    | —      | ns   | 1       |
| Transition time (rise and fall)                        | t <sub>T</sub>  |                  | 1                     | 5      | ns   |         |
| Refresh period   | t <sub>REF</sub>  |                  | —                     | 64     | ms   |         |

## HM5225645F-B60, HM5225325F-B60

- Notes:
1. AC measurement assumes  $t_T = 1$  ns. Reference level for timing of input signals is 1.5 V.
  2. Access time is measured at 1.5 V. Load condition is  $CL = 50$  pF.
  3.  $t_{LZ}$  (min) defines the time at which the outputs achieves the low impedance state.
  4.  $t_{HZ}$  (max) defines the time at which the outputs achieves the high impedance state.
  5.  $t_{CES}$  define CKE setup time to CLK rising edge except power down exit command.
  6.  $t_{AS}/t_{AH}$ : Address,  $t_{CS}/t_{CH}$ :  $\overline{CS}$ ,  $\overline{RAS}$ ,  $\overline{CAS}$ ,  $\overline{WE}$ ,  $\overline{DQM}$ .  
 $t_{DS}/t_{DH}$ : Data-in,  $t_{CES}/t_{CEH}$ : CKE

### Test Conditions

- Input and output timing reference levels: 1.5 V
- Input waveform and output load: See following figures

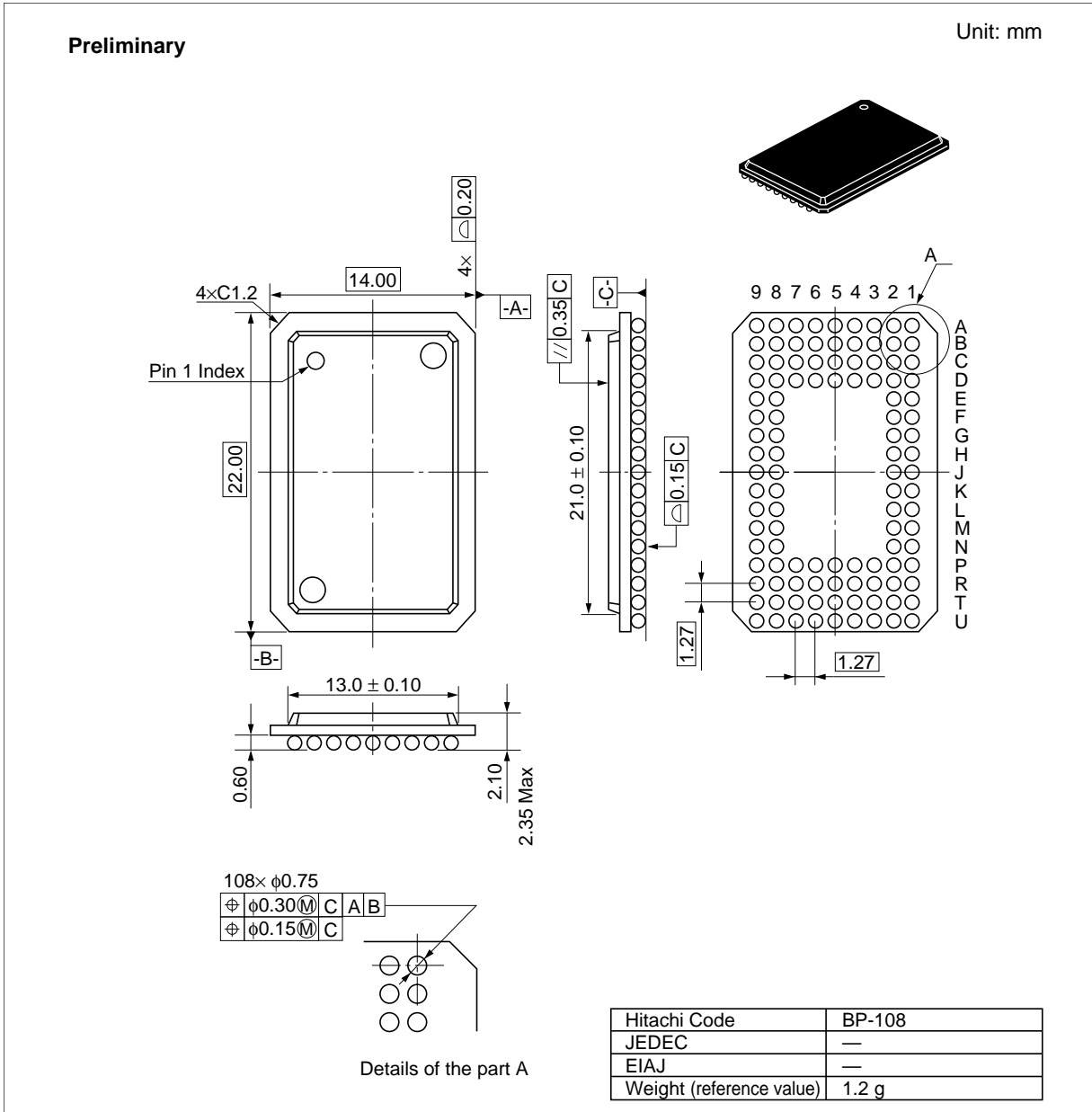


# HM5225645F-B60, HM5225325F-B60

## Package Dimensions

HM5225645FBP Series

HM5225325FBP Series (BP-108)



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## HM5225645F-B60, HM5225325F-B60

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### Revision Record

| Rev. | Date          | Contents of Modification   | Drawn by  | Approved by |
|------|---------------|--|-----------|-------------|
| 0.0  | Feb. 1, 1999  | Initial issue  | S. Hatano | S. Hatano   |
| 0.1  | Feb. 19, 1999 | Pin arrangement<br>Correct pin No. to JEDEC standard<br>Package dimension<br>Correct illustration and indexes  | S. Hatano | S. Hatano   |
| 0.2  | Apr. 1, 1999  | Ordering information<br>Correct error of type No.  | S. Hatano | S. Hatano   |
| 1.0  | Oct. 1, 1999  | Programmable $\overline{CAS}$ latency: 3 to 2/3<br>Ordering information<br>Addition of note<br>Pin description<br>Addition of note 1<br>DC Characteristics (HM5225645F)<br>$I_{CC1}$ max (CL = 2): 280 mA to 200 mA<br>$I_{CC1}$ max (CL = 3): 300 mA to 220 mA<br>$I_{CC4}$ max (CL = 2): 280 mA to 220 mA<br>$I_{CC4}$ max (CL = 3): 360 mA to 270 mA<br>$I_{CC5}$ max: 460 mA to 380 mA<br>DC Characteristics (HM5225325F)<br>$I_{CC1}$ max (CL = 2): 260 mA to 180 mA<br>$I_{CC1}$ max (CL = 3): 280 mA to 200 mA<br>$I_{CC4}$ max (CL = 2): 260 mA to 200 mA<br>$I_{CC4}$ max (CL = 3): 320 mA to 250 mA<br>$I_{CC5}$ max: 460 mA to 380 mA<br>Capacitance<br>$C_{H1}$ max: 16 pF to 14 pF<br>$C_{H2}$ max: 20 pF to 14 pF<br>$C_O$ min: 4 pF to 3 pF<br>$C_O$ max: 6.5 pF to 5 pF<br>Package dimension<br>Change tolerance of height |           |             |

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